

# International IR Rectifier

PD - 95957

## IRF5305S/LPbF

- Lead-Free
- Advanced Process Technology
- Surface Mount (IRF5305S)
- Low-profile through-hole (IRF5305L)
- 175°C Operating Temperature
- Fast Switching
- P-Channel
- Fully Avalanche Rated

### Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D<sup>2</sup>Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D<sup>2</sup>Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

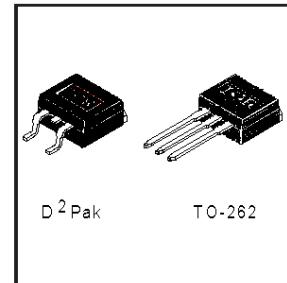
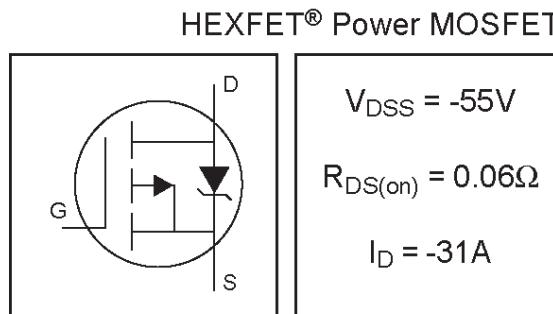
The through-hole version (IRF5305L) is available for low-profile applications.

### Absolute Maximum Ratings

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>⑤</sup>	-31	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>⑤</sup>	-22	A
I <sub>DM</sub>	Pulsed Drain Current ①②	-110	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation	3.8	W
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	110	W
	Linear Derating Factor	0.71	W/C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>②⑤</sup>	280	mJ
I <sub>AR</sub>	Avalanche Current <sup>①</sup>	-16	A
E <sub>AR</sub>	Repetitive Avalanche Energy <sup>①</sup>	11	mJ
dv/dt	Peak Diode Recovery dv/dt <sup>③⑤</sup>	-5.8	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	

### Thermal Resistance

	Parameter	Typ.	Max.	Units
R <sub>θJC</sub>	Junction-to-Case	—	1.4	
R <sub>θJA</sub>	Junction-to-Ambient ( PCB Mounted,steady-state)**	—	40	°C/W



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## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-55	—	—	V	$V_{GS} = 0V, I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	-0.034	—	$\text{V}^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = -1\text{mA}$ ⑤
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.06	$\Omega$	$V_{GS} = -10V, I_D = -16\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	-2.0	—	-4.0	V	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
$g_{fs}$	Forward Transconductance	8.0	—	—	S	$V_{DS} = -25V, I_D = -16\text{A}$ ⑤
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	-25	$\mu\text{A}$	$V_{DS} = -55V, V_{GS} = 0V$
		—	—	-250		$V_{DS} = -44V, V_{GS} = 0V, T_J = 150^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20V$
$Q_g$	Total Gate Charge	—	—	63	nC	$I_D = -16\text{A}$
$Q_{gs}$	Gate-to-Source Charge	—	—	13		$V_{DS} = -44V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	—	29		$V_{GS} = -10V$ , See Fig. 6 and 13 ④⑤
$t_{d(on)}$	Turn-On Delay Time	—	—	14	—	ns
$t_r$	Rise Time	—	—	66	—	
$t_{d(off)}$	Turn-Off Delay Time	—	—	39	—	
$t_f$	Fall Time	—	—	63	—	
$L_S$	Internal Source Inductance	—	—	7.5	nH	Between lead, and center of die contact
$C_{iss}$	Input Capacitance	—	—	1200	—	pF
$C_{oss}$	Output Capacitance	—	—	520	—	
$C_{rss}$	Reverse Transfer Capacitance	—	—	250	—	
						$f = 1.0\text{MHz}$ , See Fig. 5⑤

## Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	-31	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	-110		
$V_{SD}$	Diode Forward Voltage	—	—	-1.3		$T_J = 25^\circ\text{C}, I_S = -16\text{A}, V_{GS} = 0V$ ④
$t_{rr}$	Reverse Recovery Time	—	71	110	ns	$T_J = 25^\circ\text{C}, I_F = -16\text{A}$
$Q_{rr}$	Reverse Recovery Charge	—	170	250	nC	$dI/dt = -100\text{A}/\mu\text{s}$ ④⑤
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ )				

### Notes:

① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )

④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

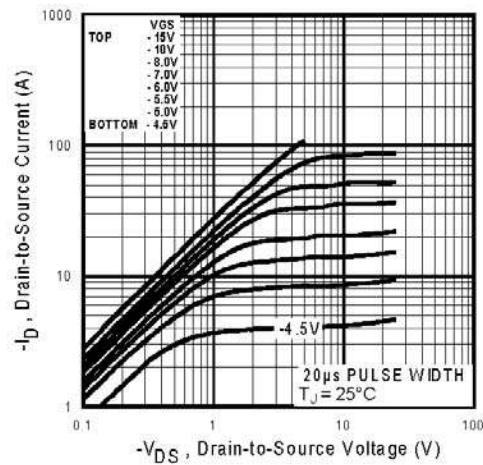
②  $V_{DD} = -25V$ , Starting  $T_J = 25^\circ\text{C}$ ,  $L = 2.1\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = -16\text{A}$ . (See Figure 12)

⑤ Uses IRF5305 data and test conditions

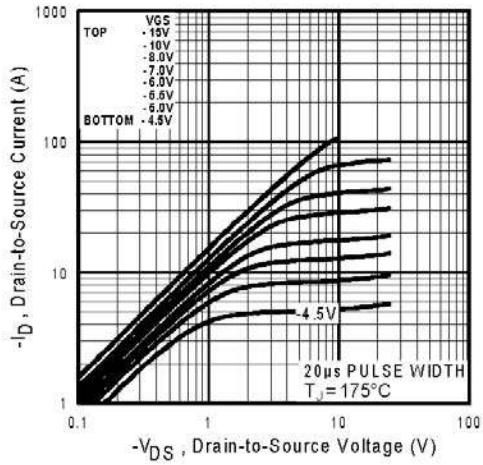
③  $I_{SD} \leq -16\text{A}$ ,  $dI/dt \leq -280\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})\text{DSS}}$ ,  
 $T_J \leq 175^\circ\text{C}$

\*\* When mounted on 1" square PCB (FR-4 or G-10 Material ).

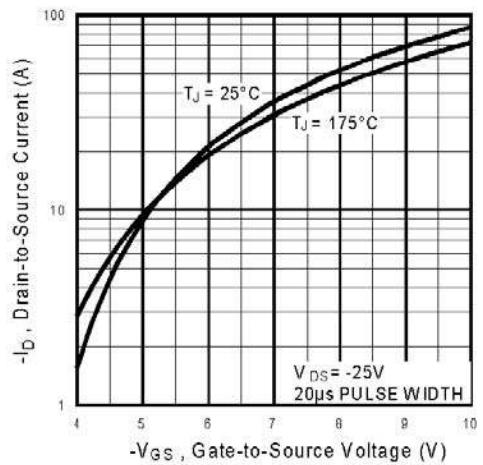
For recommended footprint and soldering techniques refer to application note #AN-994.



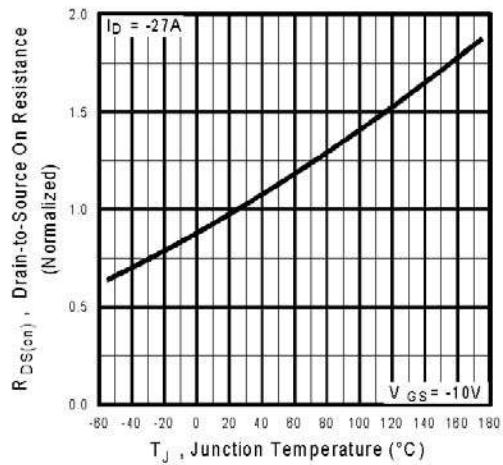
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



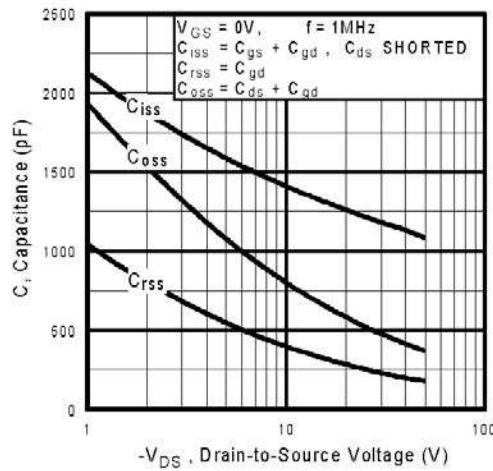
**Fig 3.** Typical Transfer Characteristics



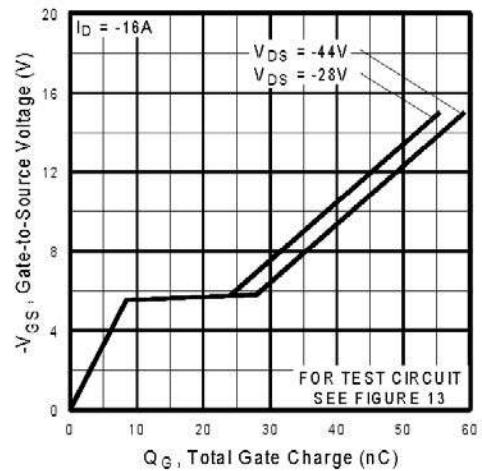
**Fig 4.** Normalized On-Resistance  
Vs. Temperature

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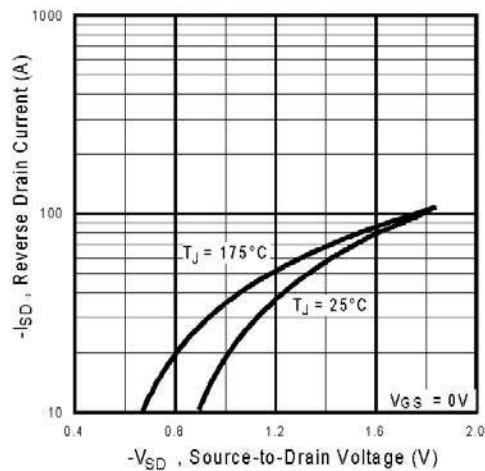
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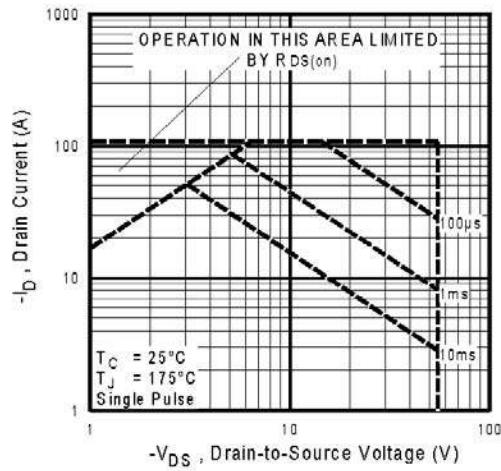
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



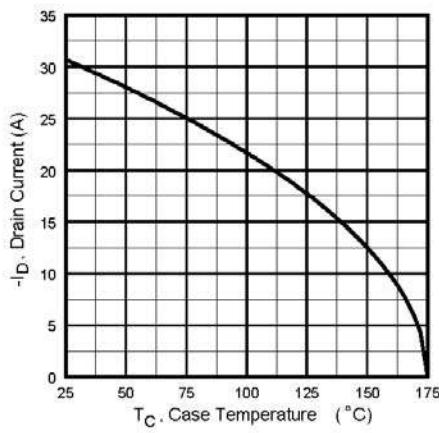
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



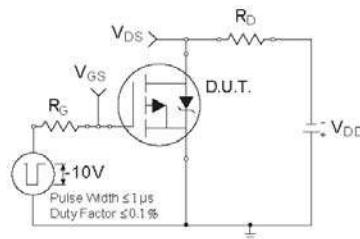
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



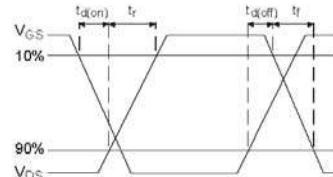
**Fig 8.** Maximum Safe Operating Area



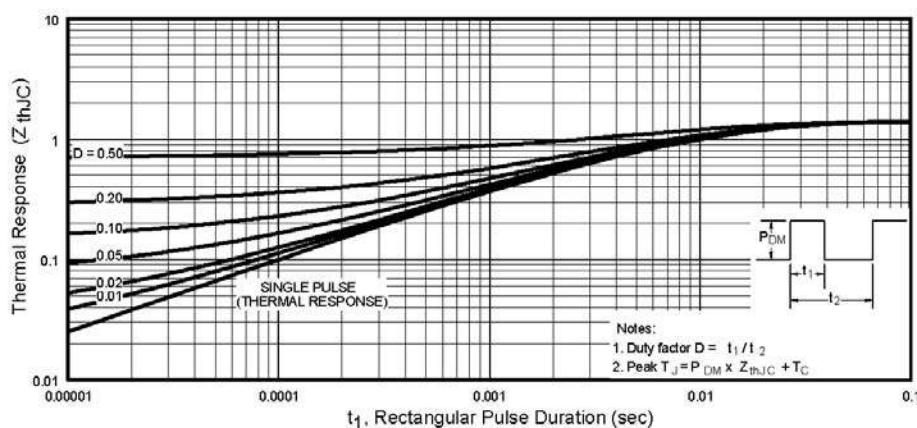
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit



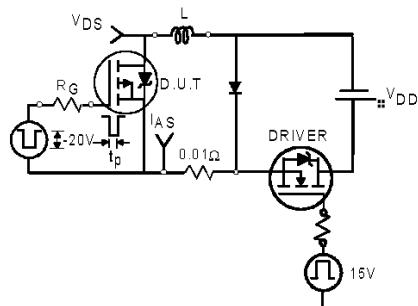
**Fig 10b.** Switching Time Waveforms



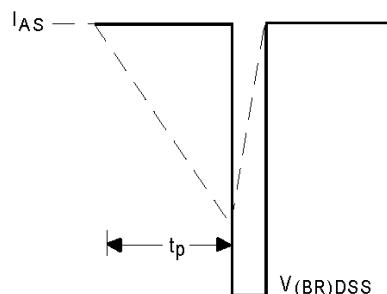
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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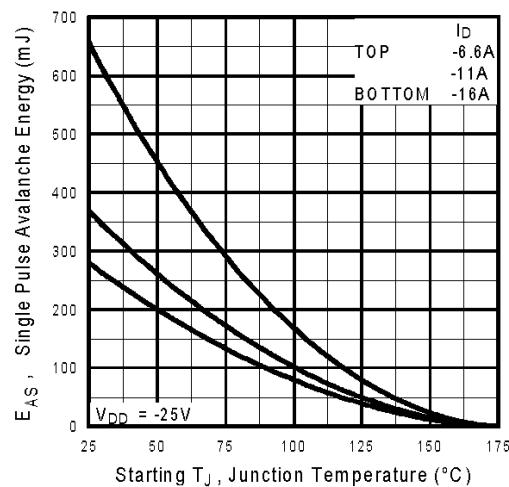
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**IR** Rectifier



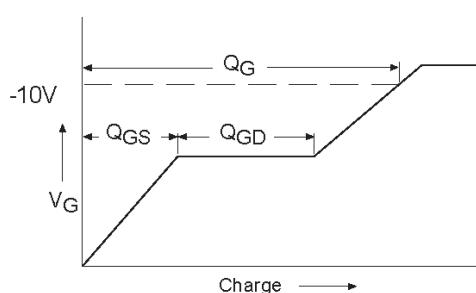
**Fig 12a.** Unclamped Inductive Test Circuit



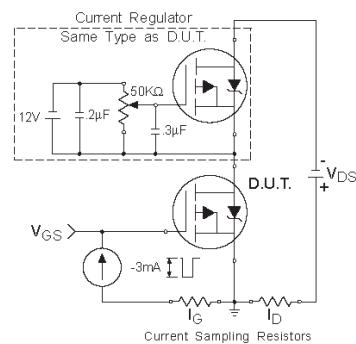
**Fig 12b.** Unclamped Inductive Waveforms



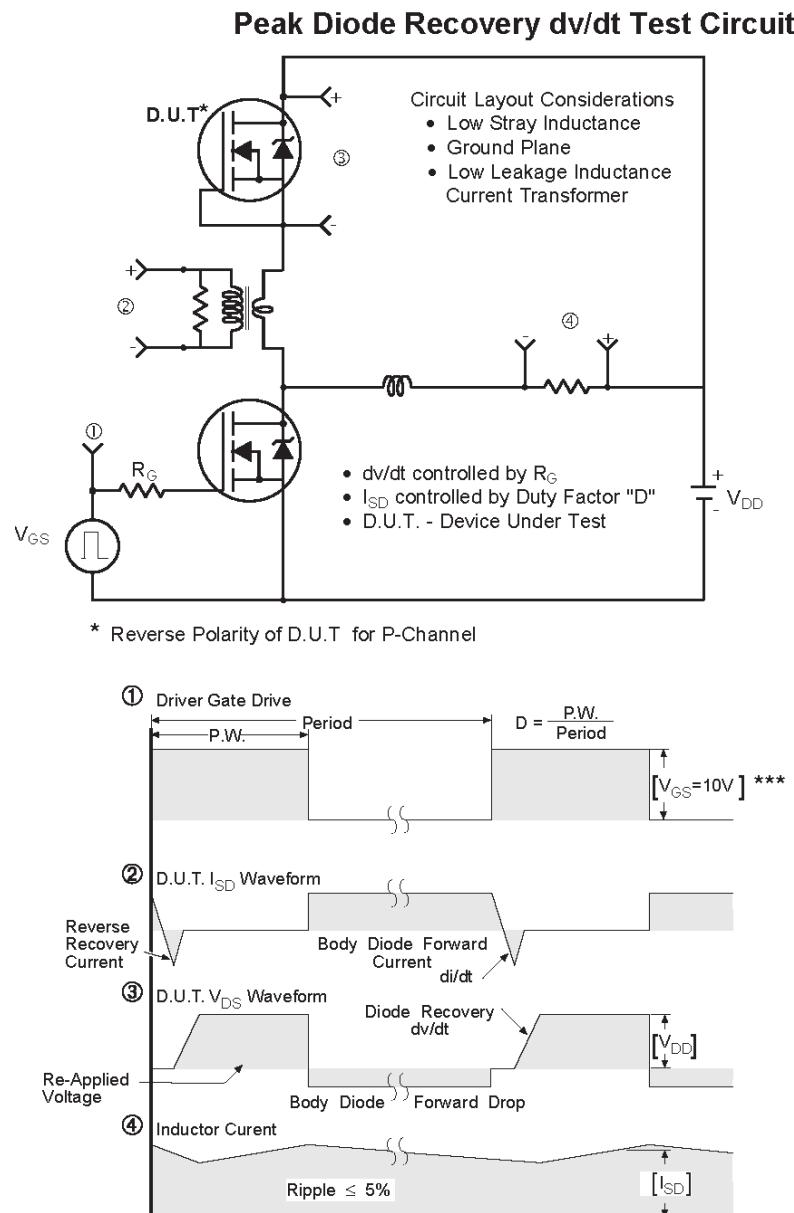
**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

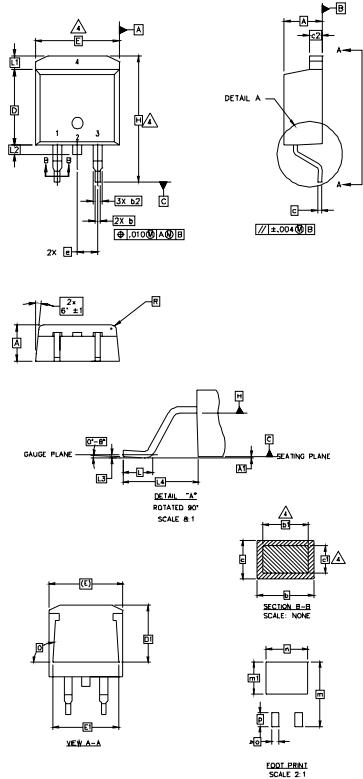


**Fig 14.** For P-Channel HEXFETS

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## D<sup>2</sup>Pak Package Outline



### NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.

5. CONTROLLING DIMENSION: INCH.

S Y M O	DIMENSIONS		N O T E S
	MILLIMETERS	INCHES	
L	MIN.	MAX.	
A	4.06	4.83	.160 .190
A1	0.00	0.254	.000 .010
b	0.51	0.99	.020 .039
b1	0.51	0.89	.020 .035
b2	1.14	1.78	.045 .070
c	0.38	0.74	.015 .029
c1	0.38	0.58	.015 .023
c2	1.14	1.65	.045 .065
D	8.51	9.65	.335 .380
D1	6.86		.270
E	9.65	10.67	.380 .420
E1	6.22		.245
e	2.54	BSC	.100 BSC
H	14.61	15.88	.575 .625
L	1.78	2.79	.070 .110
L1		1.65	.065
L2	1.27	1.78	.050 .070
L3		0.25 BSC	.010 BSC
L4	4.78	5.28	.188 .208
m	17.78		.700
m1	8.89		.350
n	11.43		.450
o	2.08		.082
p	3.81		.150
R	0.51	0.71	.020 .028
S	90°	93°	90° 93°*

### LEAD ASSIGNMENTS

#### HEXFET

1. GATE
- 2, 4. DRAIN
3. SOURCE

### IGBTs, CoPACK

1. GATE
- 2, 4. COLLECTOR
3. Emitter

### DIODES

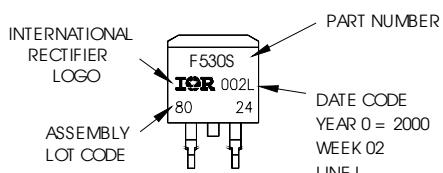
1. ANODE \*
- 2, 4. CATHODE
3. ANODE

\* PART DEPENDENT.

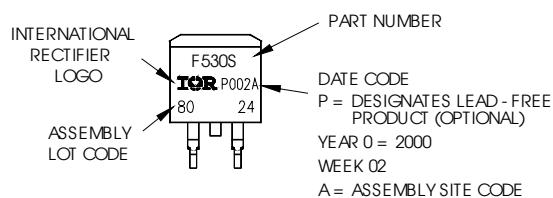
## D<sup>2</sup>Pak Part Marking Information

EXAMPLE: THIS IS AN IRF5305 WITH  
LOT CODE 8024  
ASSEMBLED ON WW02, 2000  
IN THE ASSEMBLY LINE "L"

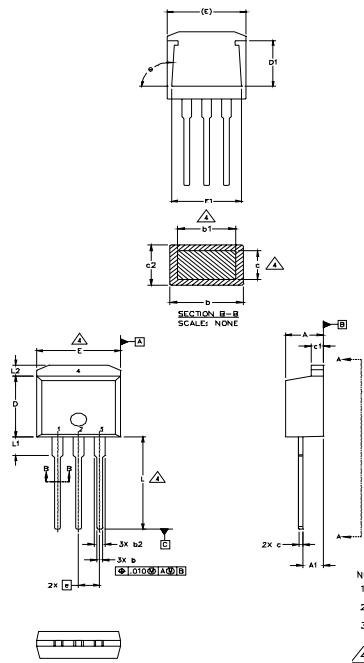
Note: "P" in assembly line position  
indicates "Lead - Free"



OR



## TO-262 Package Outline



SYMBOL	DIMENSIONS				NOTES	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	4.06	4.83	.160	.190		
A1	2.03	2.92	.080	.115	4	
b	0.51	0.99	.020	.039		
b1	0.51	0.89	.020	.035		
b2	1.14	1.40	.045	.055		
c	0.38	0.63	.015	.025	4	
c1	1.14	1.40	.045	.055		
c2	0.43	.063	.017	.029		
D	8.51	9.65	.335	.380	3	
D1	5.33		.210			
E	9.65	10.67	.380	.420	3	
E1	6.22		.245			
e	2.54	BSC	.100	BSC		
L	13.46	14.09	.530	.555		
L1	3.56	3.71	.140	.146		
L2		1.65		.065		

### LEAD ASSIGNMENTS

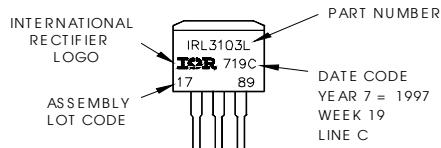
HEXFET	IGBT
1. - GATE	1 - GATE
2. - DRAIN	2 - COLLECTOR
3. - SOURCE	3 - Emitter
4. - DRAIN	

- NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
  2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
  3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
  4. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
  5. CONTROLLING DIMENSION: INCH.

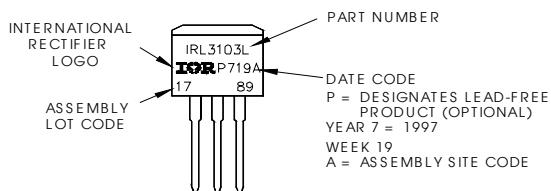
## TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 1997  
 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line  
 position indicates "Lead-Free"



OR

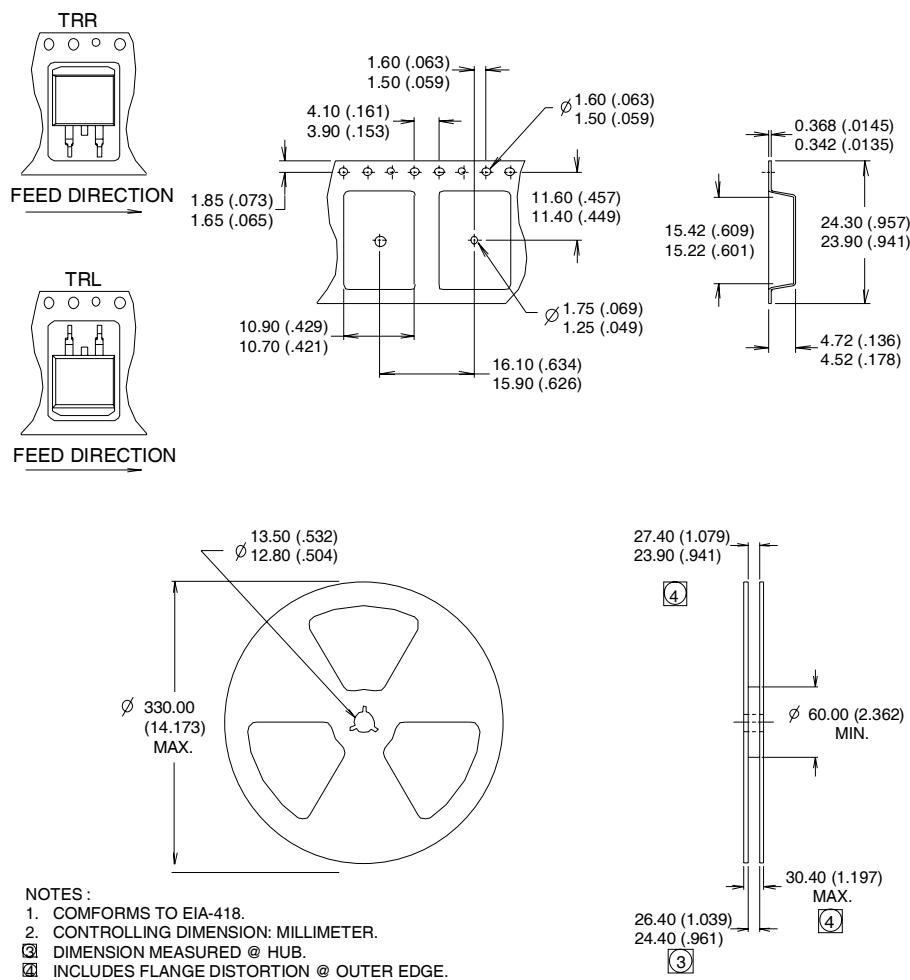


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## D<sup>2</sup>Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



Data and specifications subject to change without notice.

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**IR WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
TAC Fax: (310) 252-7903

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Note: For the most current drawings please refer to the IR website at:  
<http://www.irf.com/package/>